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PC924L0NSZ0F Series

Gate Drive DIP 8 pin *OPIC Photocoupler



■ Description

PC924L0NSZ0F Series contains an IRED optically coupled to an OPIC chip.

It is packaged in a 8 pin DIP, available in SMT gullwing lead form option.

Input-output isolation voltage(rms) is 5.0kV. CMR is MIN. $15kV/\mu s$.

■ Features

- 1. 8 pin DIP package
- 2. Double transfer mold package (Ideal for Flow Soldering)
- 3. Built-in direct drive circuit for IGBT drive

 $(I_{O1P}, I_{O2P} : 0.6A)$

4. Wide operating supply voltage range

(V_{CC}: 15 to 30V)

5. High noise immunity due to high instantaneous common mode rejection voltage

 $(CM_H : MIN. -15kV/\mu s, CM_L : MIN. 15kV/\mu s)$

- 6. High isolation voltage between input and output (V_{iso(rms)}: 5.0 kV)
- 7. Lead-free and RoHS directive compliant

■ Agency approvals/Compliance

- Recognized by UL1577 (Double protection isolation), file No. E64380 (as model No. PC924L)
- 2. Approved by VDE, DIN EN60747-5-2^(*) (as an option), file No. 40008898 (as model No. **PC924L**)
- 3. Package resin: UL flammability grade (94V-0)

■ Applications

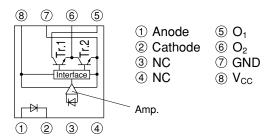
1. IGBT/MOSFET gate drive for inverter control

^(*) DIN EN60747-5-2: successor standard of DIN VDE0884

^{* &}quot;OPIC"(Optical IC) is a trademark of the SHARP Corporation. An OPIC consists of a light-detecting element and a signal-processing circuit integrated onto a single chip.



■ Internal Connection Diagram

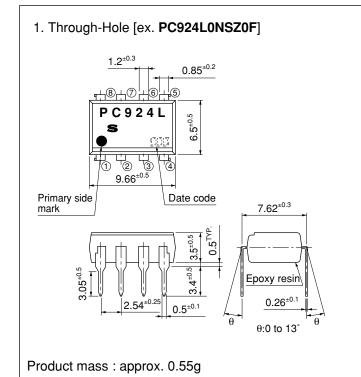


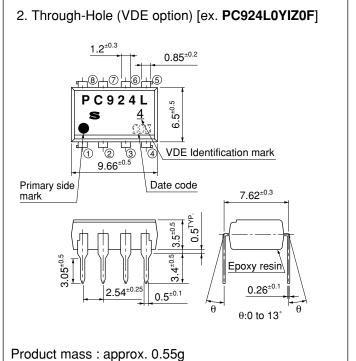
■ Truth table

Input	O ₂ Terminal Output	Tr.1	Tr.2
ON	High level	ON	OFF
OFF	Low level	OFF	ON

■ Outline Dimensions

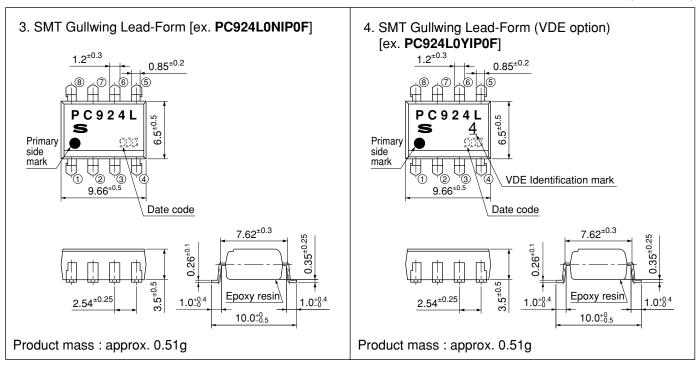
(Unit: mm)







(Unit: mm)



Plating material: SnCu (Cu: TYP. 2%)



Date code (3 digit)

1st digit				2nd digit		3rd digit		
Year of production				Month of production		Week of production		
A.D.	Mark	A.D	Mark	Month	Mark	Week	Mark	
1990	A	2002	P	January	1	1st	1	
1991	В	2003	R	February	2	2nd	2	
1992	С	2004	S	March	3	3rd	3	
1993	D	2005	T	April	4	4th	4	
1994	Е	2006	U	May	5	5.6th	5	
1995	F	2007	V	June	6			
1996	Н	2008	W	July	7			
1997	J	2009	X	August	8			
1998	K	2010	A	September	9			
1999	L	2011	В	October	0			
2000	M	2012	С	November	N			
2001	N	:	i	December	D			

repeats in a 20 year cycle

Country of origin Japan

Rank mark

There is no rank mark indicator.



■ Absolute Maximum Ratings (T_a=25°C)

	Parameter	Symbol	Rating	Unit		
Input	*1 Forward current	I_{F}	25	mA		
InI	Reverse voltage	V_R	6	V		
	Supply voltage	V_{CC}	35	V		
	O ₁ output current	I_{O1}	0.1	A		
Ħ	*2O ₁ peak output current	I _{O1P}	0.6	A		
Output	O ₂ output current	I_{O2}	0.1	A		
0	*2 O ₂ peak output current	I _{O2P}	0.6	A		
	O ₁ output voltage	V_{O1}	35	V		
	*3 Power dissipation	Po	500	mW		
*4 Total power dissipation		P _{tot}	550	mW		
*5 Isolation voltage		V _{iso (rms)}	5.0	kV		
Operating temperature		Topr	-40 to +100	°C		
Storage temperature		T_{stg}	-55 to +125	°C		
*6 Soldering temperature		T _{sol}	270	°C		

^{*1} The derating factors of a absolute maximum ratings due to ambient temperature are shown in Fig.10

■ Electro-optical Characteristics*7

(Unless otherwise specified $T_a=T_{opr}$)

	Parameter		Symbol	Conditions	MIN.	TYP.	MAX.	Unit
	Ι,	Engyland yealtage		$T_a=25$ °C, $I_F=20$ mA	-	1.2	1.4	V
Input		Forward voltage	V_{F2}	$T_a=25^{\circ}C, I_F=0.2mA$	0.6	0.9	-	V
Ing		Reverse current	I_R	$T_a=25^{\circ}C, V_R=4V$	ı	-	10	μA
	,	Terminal capacitance	Ct	$T_a=25$ °C, V=0, f=1kHz	ı	30	250	pF
	,	Supply voltage	V_{CC}	_	15	_	30	V
		O ₁ low level output voltage		V_{CC1} =12V, V_{CC2} =-12V I_{O1} =0.1A, I_F =10mA	-	0.2	0.4	V
Output	(O ₂ high level output voltage	V_{O2H}	$V_{CC}=V_{O1}=24V, I_{O2}=-0.1A, I_{F}=10mA$	20	22	-	V
Out		O ₂ low level output voltage	V _{O2L}	$V_{CC}=24V$, $I_{O2}=0.1A$, $I_{F}=0$	ı	0.5	0.8	V
	O ₁ leak current		I_{O1L}	$V_{CC}=V_{O1}=35V, I_{F}=0$	-	_	500	μΑ
	O ₂ leak current		I_{O2L}	$V_{CC}=V_{O2}=35V, I_F=10mA$	-	_	500	μΑ
	*9	*9 High level supply current		$V_{CC}=24V$, $I_F=10mA$	_	1.3	3.0	mA
	*9 Low level supply current		I_{CCL}	$V_{CC}=24V, I_{F}=0$	_	1.3	3.0	mA
	*8	"Low→High" input threshold current	I_{FLH}	$T_a=25$ °C, $V_{CC}=24$ V	1.0	4.0	7.0	mA
		Low-ringh input threshold current	1FLH	$V_{CC}=24V$	0.6	_	10.0	mA
ics	্রত্ত্ব Isolation resistance		R _{ISO}	T _a =25°C, DC500V, 40 to 60%RH	5×10 ¹⁰	10^{11}	_	Ω
erist	ime	"Low→High" propagation delay time	t _{PLH}			1.0	2.0	μs
act(se t	"High→Low" propagation delay time	t _{PHL}	$T_a=25$ °C, $V_{CC}=24$ V, $I_F=10$ mA	_	1.0	2.0	μs
har	spor	$ \begin{tabular}{lllllllllllllllllllllllllllllllllll$		$R_G=47\Omega, C_G=3\ 000pF$	_	0.2	0.5	μs
Er C	Re				_	0.2	0.5	μs
Transfer characteristics	1	Instantaneous common mode rejection voltage (High level output)		$\begin{split} & T_a \!\!=\!\! 25^{\circ} C, V_{CM} \!\!=\!\! 1.5 kV(p \!\!-\!\! p) \\ & I_F \!\!=\!\! 10 mA, V_{CC} \!\!=\!\! 24V, \Delta V_{O2H} \!\!=\!\! 2.0V \end{split}$	-15	-	-	kV/μs
		Instantaneous common mode rejection voltage (Low level output)		T_a =25°C, V_{CM} =1.5kV(p-p) I_F =0, V_{CC} =24V, ΔV_{O2L} =2.0V	15	-	_	kV/μs

^{*7} It shall connect a by-pass capacitor of $0.01\mu F$ or more between V_{CC} (pin 8) and GND (pin 7) near the device, when it measures the transfer characteristics and the output side characteristics

^{*2} Pulse width≤0.15µs, Duty ratio : 0.01

 $^{*3,\,4}$ The derating factors of a absolute maximum ratings due to ambient temperature are shown in Fig.11

^{*5} AC for 1minute, 40 to 60%RH, f=60Hz

^{*6} For 10s

^{*8} I_{FLH} represents forward current when output goes from "Low" to "High"

^{*9} O₂ output terminal is set to open



■ Model Line-up

Lead Form	Throug	h-Hole	SMT Gullwing				
Sleeve					Taping		
Package	50pcs/sleeve				1 000pcs/reel		
DIN EN60747-5-2		Approved		Approved		Approved	
Model No.	PC924L0NSZ0F	PC924L0YSZ0F	PC924L0NIZ0F	PC924L0YIZ0F	PC924L0NIP0F	PC924L0YIP0F	

Please contact a local SHARP sales representative to inquire about production status.



Fig.1 Test Circuit for O₁ Low Level Output Voltage

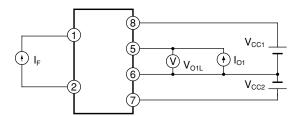


Fig.2 Test Circuit for O₂ High Level Output Voltage

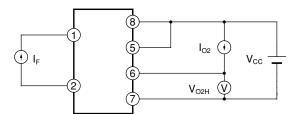


Fig.3 Test Circuit for O₂ Low Level Output Voltage

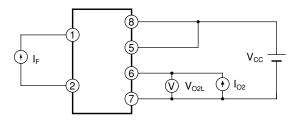


Fig.4 Test Circuit for O₁ Leak Current

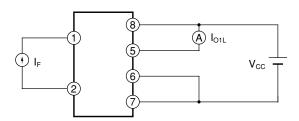


Fig.5 Test Circuit for O₂ Leak Current

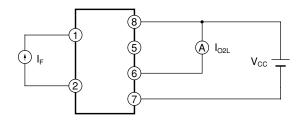


Fig.6 Test Circuit for High Level / Low Level Supply Current

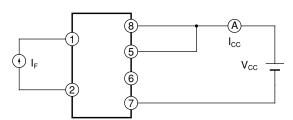




Fig.7 Test Circuit for "Low→High" Input Threshold Current

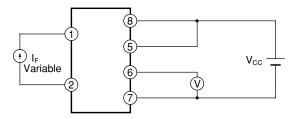
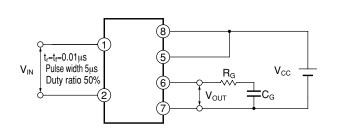


Fig.8 Test Circuit for Response Time



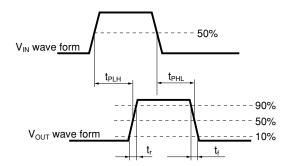
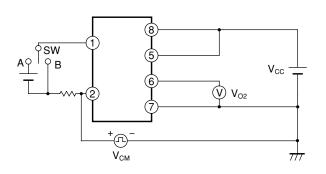


Fig.9 Test Circuit for Instantaneous Common Mode Rejection Voltage



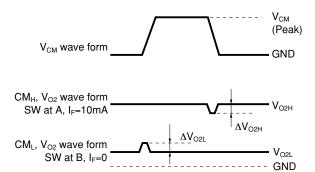




Fig.10 Forward Current vs. Ambient Temperature

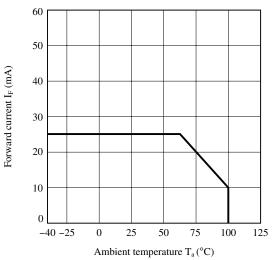


Fig.12 Forward Current vs. Forward Voltage

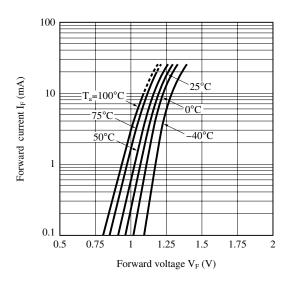


Fig.14 "Low→High" Relative Input Threshold Current vs. Ambient Temperature

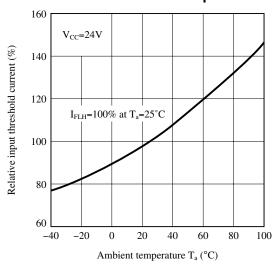


Fig.11 Power Dissipation vs. Ambient Temperature

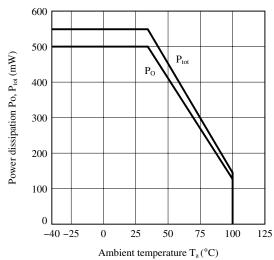


Fig.13 "Low→High" Relative Input Threshold Current vs. Supply Voltage

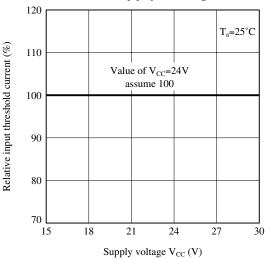


Fig.15 O₁ Low Level Output Voltage vs. O₁ Output Current

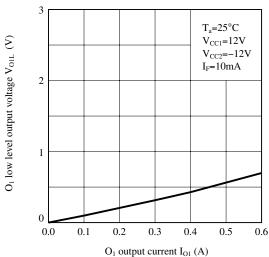




Fig.16 O₁ Low Level Output Voltage vs. Ambient Temperature

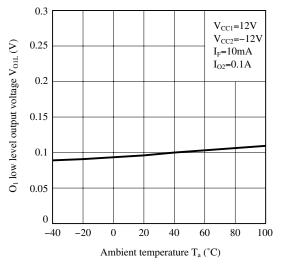


Fig.18 O₂ High Level Output Voltage vs. Supply Voltage

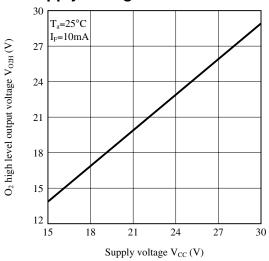


Fig.20 O₂ Low Level Output Voltage vs. O₂ Output Current

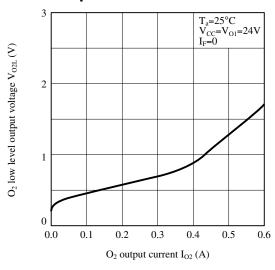


Fig.17 O₂ Output Voltage Drop vs. O₂ Output Current

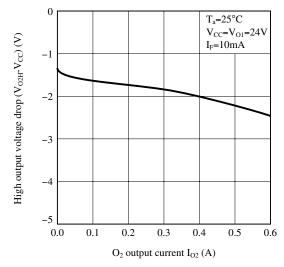


Fig.19 O₂ High Level Output Voltage vs. Ambient Temperature

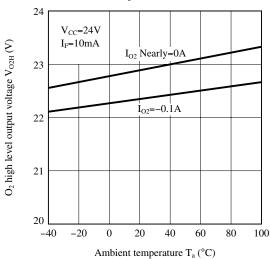
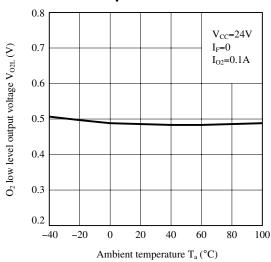


Fig.21 O₂ Low Level Output Voltage vs. Ambient Temperature



Sheet No.: D2-A06102EN



Fig.22 High Level Supply Current vs. **Supply Voltage**

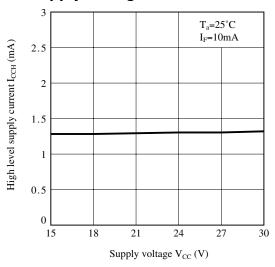


Fig.23 Low Level Supply Current vs. **Supply Voltage**

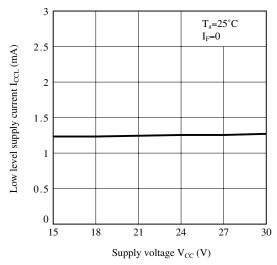
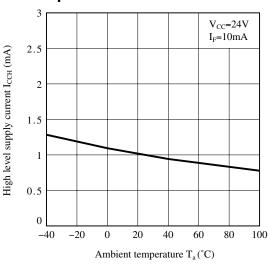


Fig.24 High Level Supply Current vs. Ambient Fig.25 Low Level Supply Current vs. **Temperature**



Ambient Temperature

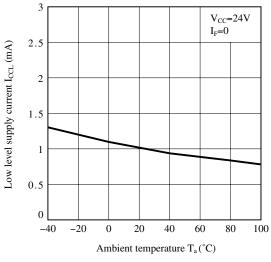


Fig.26 Propagation Delay Time vs. Forward Current

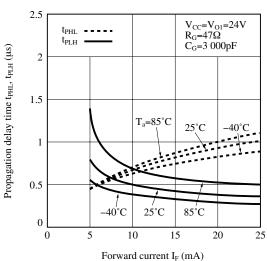
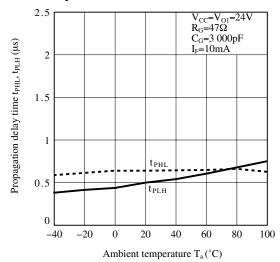


Fig.27 Propagation Delay Time vs. Ambient **Temperature**



Remarks: Please be aware that all data in the graph are just for reference and not for guarantee.



■ Design Considerations

Recommended operating conditions

Parameter	Symbol	MIN.	TYP.	MAX.	Unit
Forward current	I_{F}	14	-	20	mA
Supply voltage	V _{CC}	15	_	30	V
Operating temperature	Topr	-40	_	70	°C

Notes about static electricity

Transistor of detector side in bipolar configuration may be damaged by static electricity due to its minute design.

When handling these devices, general countermeasure against static electricity should be taken to avoid breakdown of devices or degradation of characteristics.

Design guide

In order to stabilize power supply line, we should certainly recommend to connect a by-pass capacitor of $0.01\mu F$ or more between V_{CC} and GND near the device.

In case that some sudden big noise caused by voltage variation is provided between primary and secondary terminals of photocoupler some current caused by it is floating capacitance may be generated and result in false operation since current may go through IRED or current may change.

If the photocoupler may be used under the circumstances where noise will be generated we recommend to use the bypass capacitors at the both ends of IRED.

The detector which is used in this device, has parasitic diode between each pins and GND.

There are cases that miss operation or destruction possibly may be occurred if electric potential of any pin becomes below GND level even for instant.

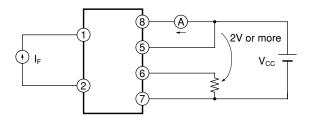
Therefore it shall be recommended to design the circuit that electric potential of any pin does not become below GND level.

This product is not designed against irradiation and incorporates non-coherent IRED.

This photocoupler is dedicated to the use for IGBT or MOSFET Gate Drive.

Please do not use this for the other application.

As mentioned below, when the input is on, if DC load (resistor etc.) is connected between O_2 output pin 6 and GND pin 7 and if the electric potential V_{O2} goes approx. 2V below than electric potential V_{CC} pin 8 continuously, supply current I_{CC} may flow more than usually and go beyond power dissipation.





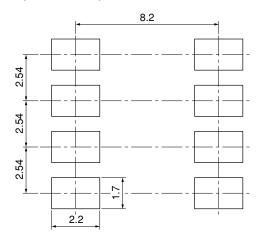
Degradation

In general, the emission of the IRED used in photocouplers will degrade over time.

In the case of long term operation, please take the general IRED degradation (50% degradation over 5 years) into the design consideration.

Please decide the input current which become 2 times of MAX. I_{FLH}.

Recommended Foot Print (reference)



(Unit:mm)

[☆] For additional design assistance, please review our corresponding Optoelectronic Application Notes.



■ Manufacturing Guidelines

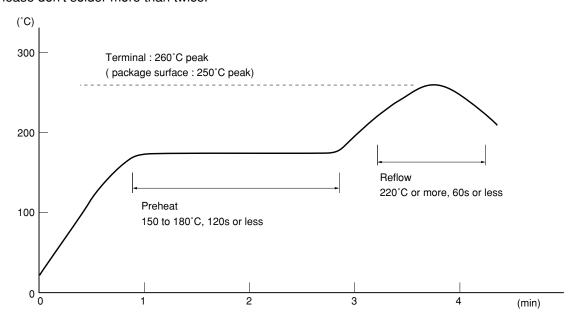
Soldering Method

Reflow Soldering:

Reflow soldering should follow the temperature profile shown below.

Soldering should not exceed the curve of temperature profile and time.

Please don't solder more than twice.



Flow Soldering:

Due to SHARP's double transfer mold construction submersion in flow solder bath is allowed under the below listed guidelines.

Flow soldering should be completed below 270°C and within 10s.

Preheating is within the bounds of 100 to 150°C and 30 to 80s.

Please don't solder more than twice.

Hand soldering

Hand soldering should be completed within 3s when the point of solder iron is below 400°C.

Please don't solder more than twice.

Other notices

Please test the soldering method in actual condition and make sure the soldering works fine, since the impact on the junction between the device and PCB varies depending on the tooling and soldering conditions.



Cleaning instructions

Solvent cleaning:

Solvent temperature should be 45°C or below Immersion time should be 3 minutes or less

Ultrasonic cleaning:

The impact on the device varies depending on the size of the cleaning bath, ultrasonic output, cleaning time, size of PCB and mounting method of the device.

Therefore, please make sure the device withstands the ultrasonic cleaning in actual conditions in advance of mass production.

Recommended solvent materials:

Ethyl alcohol, Methyl alcohol and Isopropyl alcohol

In case the other type of solvent materials are intended to be used, please make sure they work fine in actual using conditions since some materials may erode the packaging resin.

Presence of ODC

This product shall not contain the following materials.

And they are not used in the production process for this product.

Regulation substances: CFCs, Halon, Carbon tetrachloride, 1.1.1-Trichloroethane (Methylchloroform)

Specific brominated flame retardants such as the PBBOs and PBBs are not used in this product at all.

This product shall not contain the following materials banned in the RoHS Directive (2002/95/EC).

•Lead, Mercury, Cadmium, Hexavalent chromium, Polybrominated biphenyls (PBB), Polybrominated diphenyl ethers (PBDE).



■ Package specification

Sleeve package

Package materials

Sleeve: HIPS (with anti-static material)

Stopper: Styrene-Elastomer

Package method

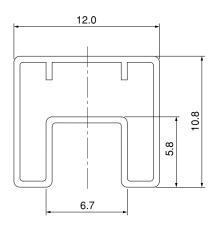
MAX. 50 pcs. of products shall be packaged in a sleeve.

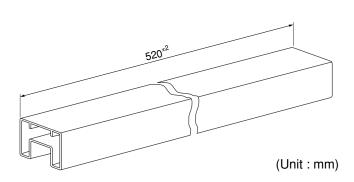
Both ends shall be closed by tabbed and tabless stoppers.

The product shall be arranged in the sleeve with its primary side mark on the tabless stopper side.

MAX. 20 sleeves in one case.

Sleeve outline dimensions







● Tape and Reel package

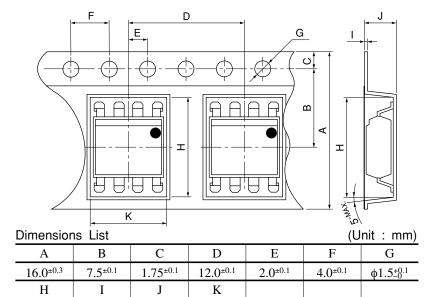
Package materials

Carrier tape: A-PET (with anti-static material)

Cover tape: PET (three layer system)

Reel: PS

Carrier tape structure and Dimensions



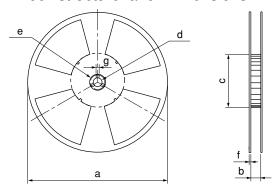
 $10.2^{\pm0.1}$

Reel structure and Dimensions

 $10.4^{\pm0.1}$

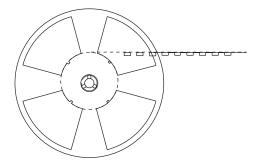
 $0.4^{\pm0.05}$

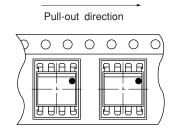
 $4.2^{\pm0.1}$



Dimensio	ns List	(Unit: mm)			
a	b	c	d		
330	17.5 ^{±1.5}	100±1.0	13±0.5		
e	f	g			
23 ^{±1.0}	2.0 ^{±0.5}	2.0 ^{±0.5}			

Direction of product insertion





[Packing: 1 000pcs/reel]



■ Important Notices

- · The circuit application examples in this publication are provided to explain representative applications of SHARP devices and are not intended to guarantee any circuit design or license any intellectual property rights. SHARP takes no responsibility for any problems related to any intellectual property right of a third party resulting from the use of SHARP's devices.
- · Contact SHARP in order to obtain the latest device specification sheets before using any SHARP device. SHARP reserves the right to make changes in the specifications, characteristics, data, materials, structure, and other contents described herein at any time without notice in order to improve design or reliability. Manufacturing locations are also subject to change without notice.
- · Observe the following points when using any devices in this publication. SHARP takes no responsibility for damage caused by improper use of the devices which does not meet the conditions and absolute maximum ratings to be used specified in the relevant specification sheet nor meet the following conditions:
- (i) The devices in this publication are designed for use in general electronic equipment designs such as:
 - --- Personal computers
 - --- Office automation equipment
 - --- Telecommunication equipment [terminal]
 - --- Test and measurement equipment
 - --- Industrial control
 - --- Audio visual equipment
 - --- Consumer electronics
- (ii) Measures such as fail-safe function and redundant design should be taken to ensure reliability and safety when SHARP devices are used for or in connection

with equipment that requires higher reliability such as:

- --- Transportation control and safety equipment (i.e., aircraft, trains, automobiles, etc.)
- --- Traffic signals
- --- Gas leakage sensor breakers
- --- Alarm equipment
- --- Various safety devices, etc.
- (iii) SHARP devices shall not be used for or in connection with equipment that requires an extremely high level of reliability and safety such as:
 - --- Space applications
 - --- Telecommunication equipment [trunk lines]
 - --- Nuclear power control equipment
 - --- Medical and other life support equipment (e.g., scuba).
- · If the SHARP devices listed in this publication fall within the scope of strategic products described in the Foreign Exchange and Foreign Trade Law of Japan, it is necessary to obtain approval to export such SHARP devices.
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